



GAN3R2-100CBE

100 V, 3.2 mOhm Gallium Nitride (GaN) FET in a
3.5 mm x 2.13 mm Wafer Level Chip-Scale Package (WLCSP)

27 April 2023

Product data sheet

1. General description

The GAN3R2-100CBE is a general purpose 100 V, 3.2 mΩ Gallium Nitride (GaN) FET in a 15 bump Wafer Level Chip-Scale Package (WLCSP). It is a normally-off e-mode device offering superior performance.

2. Features and benefits

- Enhancement mode - normally-off power switch
- Ultra high frequency switching capability
- No body diode
- Low gate charge, low output charge
- Qualified for standard applications
- ESD protection
- RoHS, Pb-free, REACH-compliant
- High efficiency and high power density
- Wafer Level Chip-Scale Package (WLCSP) 3.5 mm x 2.13 mm

3. Applications

- High power density and high efficiency power conversion
- AC-to-DC converters, (secondary stage)
- High frequency DC-to-DC converters in 48 V systems
- Fast battery charging, mobile phone, laptop, tablet and USB type-C chargers
- Datacom and telecom (AC-to-DC and DC-to-DC) converters
- Motor drives
- LiDAR (non-automotive)
- Class D audio amplifiers

4. Quick reference data

Table 1. Quick reference data

| Symbol | Parameter | Conditions | Min | Typ | Max | Unit |
|-------------------------------|-----------------------------------|--|-----|-----|-----|------|
| V_{DS} | drain-source voltage | | - | - | 100 | V |
| V_{TDS} | transient drain to source voltage | pulsed; $t_p = 1 \mu s$; $\delta_{factor} = 0.01$ | - | - | 130 | V |
| I_D | drain current | $V_{GS} = 5 V$ | [1] | - | 60 | A |
| P_{tot} | total power dissipation | Fig. 1 | - | - | 394 | W |
| T_j | junction temperature | | -40 | - | 150 | °C |
| Static characteristics | | | | | | |
| R_{DSon} | drain-source on-state resistance | $V_{GS} = 5 V$; $I_D = 25 A$; $T_j = 25 \text{ °C}$; Fig. 9 ; Fig. 10 ; Fig. 11 ; Fig. 12 | - | 2.4 | 3.2 | mΩ |
| R_G | gate resistance | $f = 5 \text{ MHz}$; $T_j = 25 \text{ °C}$ | - | 2.2 | - | Ω |

100 V, 3.2 mOhm Gallium Nitride (GaN) FET in a 3.5 mm x 2.13 mm Wafer Level Chip-Scale Package (WLCSP)

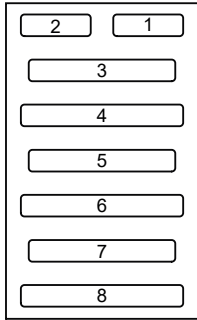
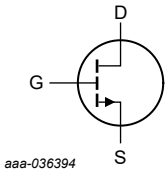
| Symbol | Parameter | Conditions | Min | Typ | Max | Unit |
|--------------------------------|-------------------|---|-----|-----|-----|------|
| Dynamic characteristics | | | | | | |
| Q_{GD} | gate-drain charge | $I_D = 25\text{ A}$; $V_{DS} = 50\text{ V}$; $V_{GS} = 5\text{ V}$; $T_j = 25\text{ °C}$; Fig. 13; Fig. 14 | - | 1.7 | - | nC |
| $Q_{G(tot)}$ | total gate charge | | - | 9.2 | 12 | nC |
| Q_{oss} | output charge | $V_{GS} = 0\text{ V}$; $V_{DS} = 50\text{ V}$; $T_j = 25\text{ °C}$ | [2] | 50 | - | nC |

[1] Limited by package

[2] Q_r is not specified separately from Q_{oss} for e-mode GaN FETs, since $Q_r = Q_{oss} + Q_D$, and $Q_D = 0$. (Q_D is charge associated with diffusion of minority carriers. Since there is no body diode, no minority carriers in excess of Q_{oss} have to be transferred for e-mode GaN FETs.)

5. Pinning information

Table 2. Pinning information

| Pin | Symbol | Description | Simplified outline | Graphic symbol |
|-----|--------|-------------|--|--|
| 1 | G | gate |  <p>Transparent top view WLCSP8 (WLCSP8-SOT8072)</p> |  <p>aaa-036394</p> |
| 2 | S | source | | |
| 3 | D | drain | | |
| 4 | S | source | | |
| 5 | D | drain | | |
| 6 | S | source | | |
| 7 | D | drain | | |
| 8 | S | source | | |

6. Ordering information

Table 3. Ordering information

| Type number | Package | | |
|---------------|---------|--|----------------|
| | Name | Description | Version |
| GAN3R2-100CBE | WLCSP8 | wafer level chip-scale package; 8 solder bars; body: 3.5 x 2.13 x 0.429 mm | WLCSP8-SOT8072 |

7. Marking

Table 4. Marking codes

| Type number | Marking code |
|---------------|--------------|
| GAN3R2-100CBE | 3R2DCBE |

8. Limiting values

Table 5. Limiting values

In accordance with the Absolute Maximum Rating System (IEC 60134). $T_j = 25\text{ °C}$ unless otherwise stated.

| Symbol | Parameter | Conditions | Min | Max | Unit |
|----------|----------------------|------------|-----|-----|------|
| V_{DS} | drain-source voltage | | - | 100 | V |

100 V, 3.2 mOhm Gallium Nitride (GaN) FET in a 3.5 mm x 2.13 mm Wafer Level Chip-Scale Package (WLCSP)

| Symbol | Parameter | Conditions | Min | Max | Unit |
|----------------------|-----------------------------------|---|-----|-----|------|
| V _{TDS} | transient drain to source voltage | pulsed; t _p = 1 μs; δ _{factor} = 0.01 | - | 130 | V |
| V _{GS} | gate-source voltage | | -4 | 6 | V |
| P _{tot} | total power dissipation | Fig. 1 | - | 394 | W |
| I _D | drain current | V _{GS} = 5 V [1] | - | 60 | A |
| I _{DM} | peak drain current | pulsed; t _p ≤ 10 μs; Fig. 2 [1] | - | 230 | A |
| T _{stg} | storage temperature | | -40 | 150 | °C |
| T _j | junction temperature | | -40 | 150 | °C |
| T _{slid(M)} | peak soldering temperature | | - | 260 | °C |

[1] Limited by package

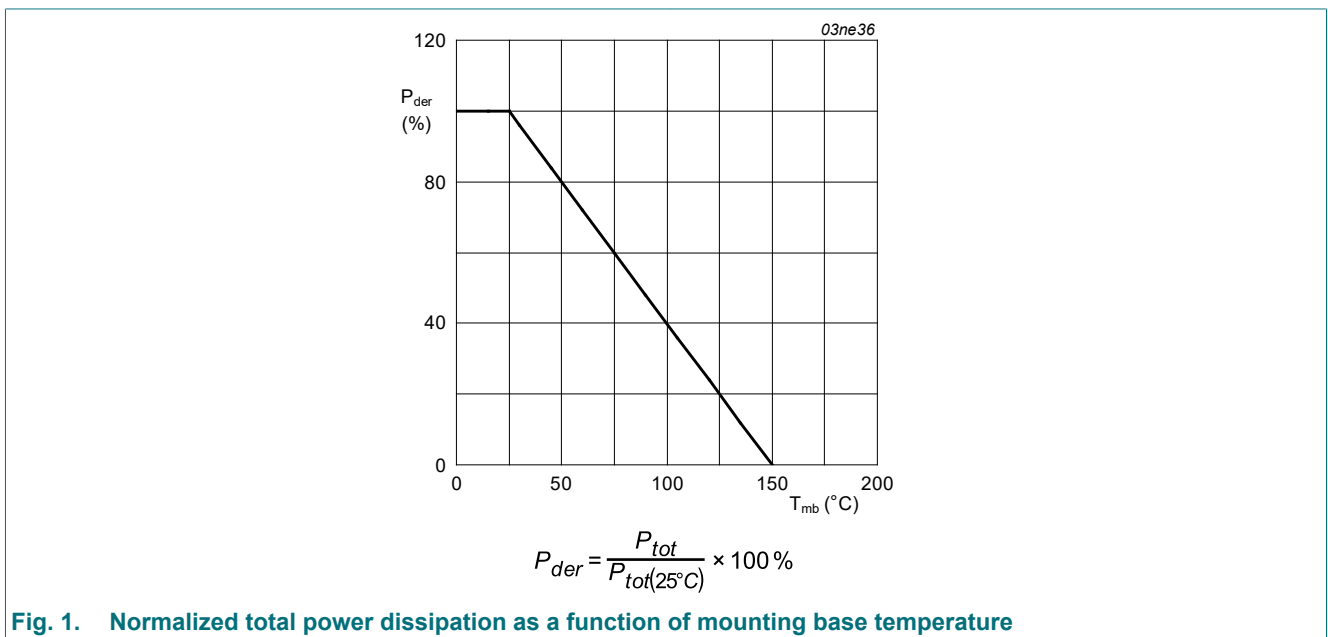


Fig. 1. Normalized total power dissipation as a function of mounting base temperature

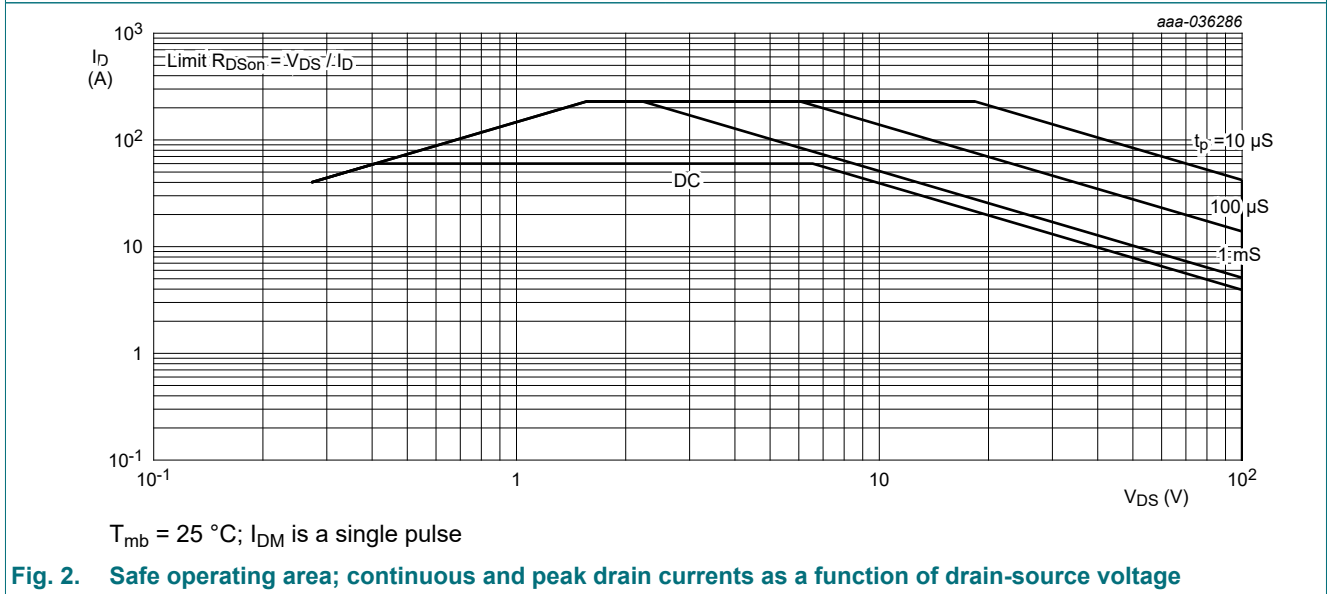


Fig. 2. Safe operating area; continuous and peak drain currents as a function of drain-source voltage

9. Thermal characteristics

Table 6. Thermal characteristics

| Symbol | Parameter | Conditions | Min | Typ | Max | Unit |
|----------------|---|------------|-----|-----|-----|------|
| $R_{th(j-c)}$ | thermal resistance from junction to case | Fig. 3 | - | - | 0.3 | K/W |
| $R_{th(j-mb)}$ | thermal resistance from junction to mounting base | | - | - | 1.5 | K/W |
| $R_{th(j-a)}$ | thermal resistance from junction to ambient | [1] | - | - | 33 | K/W |

[1] $R_{th(j-a)}$ is determined with the device mounted on one square inch of copper pad, single layer 2 oz copper on FR4 board.

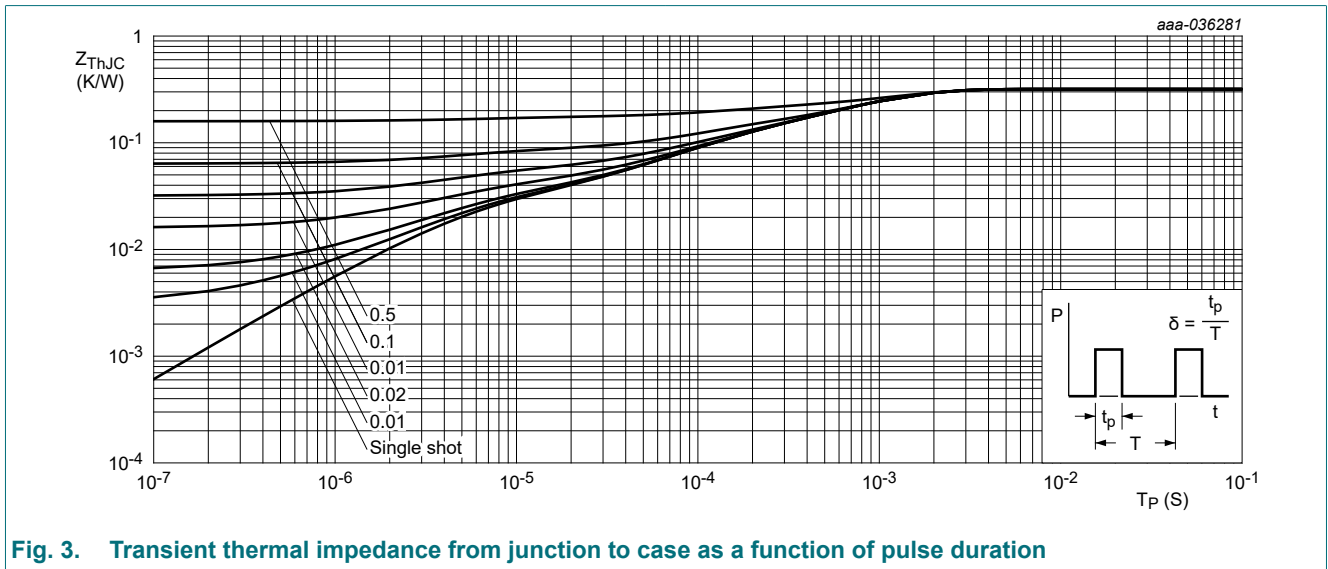


Fig. 3. Transient thermal impedance from junction to case as a function of pulse duration

10. Characteristics

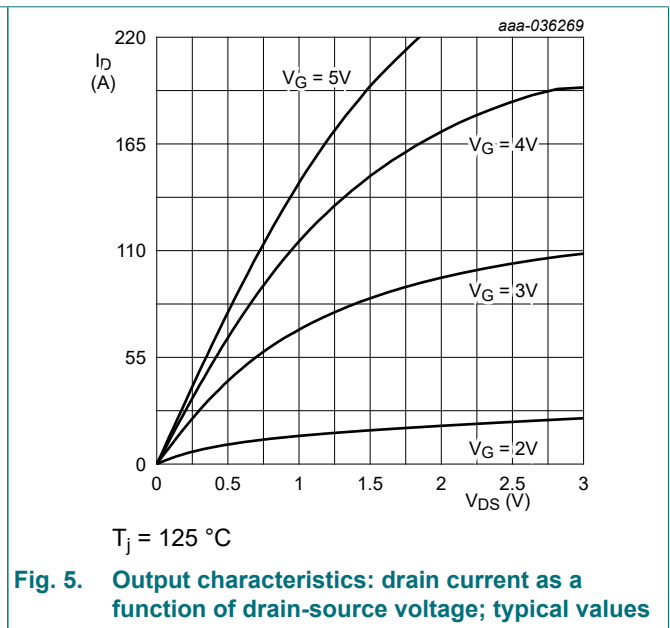
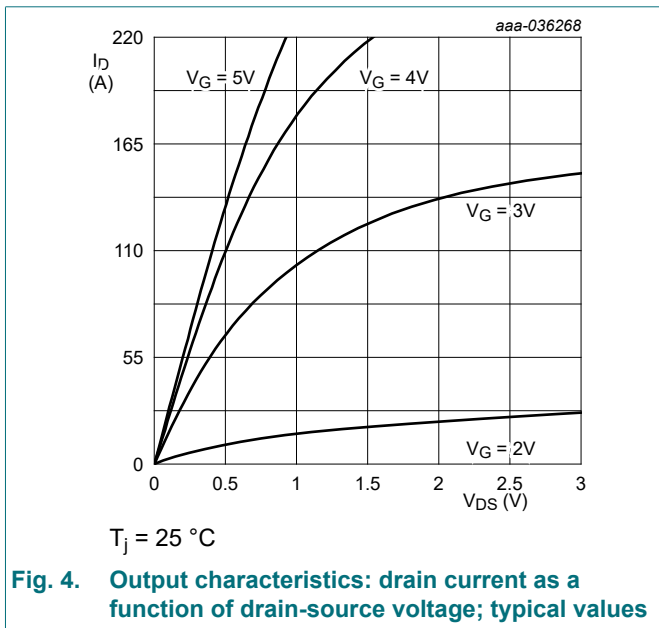
Table 7. Characteristics

| Symbol | Parameter | Conditions | Min | Typ | Max | Unit |
|-------------------------------|----------------------------------|--|-----|-----|------|------------|
| Static characteristics | | | | | | |
| $V_{(BR)DSS}$ | drain-source breakdown voltage | $I_D = 400 \mu A; V_{GS} = 0 V; T_j = 25 \text{ }^\circ C$ | 100 | - | - | V |
| $V_{GS(th)}$ | gate-source threshold voltage | $I_D = 9 \text{ mA}; V_{DS} = V_{GS}; T_j = 25 \text{ }^\circ C; \text{ Fig. 8}$ | 0.8 | 1.1 | 2.5 | V |
| I_{DSS} | drain leakage current | $V_{DS} = 80 \text{ V}; V_{GS} = 0 \text{ V}; T_j = 25 \text{ }^\circ C$ | - | 80 | 350 | μA |
| I_{GSS} | gate leakage current | $V_{GS} = 5 \text{ V}; V_{DS} = 0 \text{ V}; T_j = 25 \text{ }^\circ C$ | - | 20 | 5000 | μA |
| | | $V_{GS} = 5 \text{ V}; V_{DS} = 0 \text{ V}; T_j = 125 \text{ }^\circ C$ | - | 600 | 9000 | μA |
| | | $V_{GS} = -4 \text{ V}; V_{DS} = 0 \text{ V}; T_j = 25 \text{ }^\circ C$ | - | 60 | 400 | μA |
| R_{DSon} | drain-source on-state resistance | $V_{GS} = 5 \text{ V}; I_D = 25 \text{ A}; T_j = 25 \text{ }^\circ C; \text{ Fig. 9}; \text{ Fig. 10}; \text{ Fig. 11}; \text{ Fig. 12}$ | - | 2.4 | 3.2 | m Ω |
| R_G | gate resistance | $f = 5 \text{ MHz}; T_j = 25 \text{ }^\circ C$ | - | 2.2 | - | Ω |

100 V, 3.2 mOhm Gallium Nitride (GaN) FET in a 3.5 mm x 2.13 mm Wafer Level Chip-Scale Package (WLCSP)

| Symbol | Parameter | Conditions | Min | Typ | Max | Unit |
|-------------------------------------|--|--|-----|------|-----|------|
| Dynamic characteristics | | | | | | |
| $Q_{G(tot)}$ | total gate charge | $I_D = 25\text{ A}; V_{DS} = 50\text{ V}; V_{GS} = 5\text{ V}; T_j = 25\text{ }^\circ\text{C};$ Fig. 13 ; Fig. 14 | - | 9.2 | 12 | nC |
| Q_{GS} | gate-source charge | | - | 1.9 | - | nC |
| Q_{GD} | gate-drain charge | | - | 1.7 | - | nC |
| C_{iss} | input capacitance | $V_{DS} = 50\text{ V}; V_{GS} = 0\text{ V}; f = 100\text{ kHz}; T_j = 25\text{ }^\circ\text{C};$ Fig. 15 | - | 1000 | - | pF |
| C_{oss} | output capacitance | | - | 460 | - | pF |
| C_{rss} | reverse transfer capacitance | | - | 8.2 | - | pF |
| $C_{o(er)}$ | effective output capacitance, energy related | $0\text{ V} \leq V_{DS} \leq 50\text{ V}; V_{GS} = 0\text{ V}; T_j = 25\text{ }^\circ\text{C};$ Fig. 16 | [1] | 700 | - | pF |
| $C_{o(tr)}$ | effective output capacitance, time related | $0\text{ V} \leq V_{DS} \leq 50\text{ V}; V_{GS} = 0\text{ V}; T_j = 25\text{ }^\circ\text{C}$ | [2] | 1020 | - | pF |
| Q_{oss} | output charge | $V_{GS} = 0\text{ V}; V_{DS} = 50\text{ V}; T_j = 25\text{ }^\circ\text{C}$ | [3] | 50 | - | nC |
| Source-drain characteristics | | | | | | |
| V_{SD} | source-drain voltage | $I_S = 0.5\text{ A}; V_{GS} = 0\text{ V}; T_j = 25\text{ }^\circ\text{C};$ Fig. 17 ; Fig. 18 ; Fig. 19 ; Fig. 20 | - | 1.5 | - | V |

- [1] $C_{O(er)}$ is the fixed capacitance that gives the same stored energy as C_{OSS} while V_{DS} is rising from 0 to 50 V
- [2] $C_{O(tr)}$ is the fixed capacitance that gives the same charging time as C_{OSS} while V_{DS} is rising from 0 to 50 V
- [3] Q_r is not specified separately from Q_{oss} for e-mode GaN FETs, since $Q_r = Q_{oss} + Q_D$, and $Q_D = 0$. (Q_D is charge associated with diffusion of minority carriers. Since there is no body diode, no minority carriers in excess of Q_{oss} have to be transferred for e-mode GaN FETs.)



100 V, 3.2 mOhm Gallium Nitride (GaN) FET in a 3.5 mm x 2.13 mm Wafer Level Chip-Scale Package (WLCSP)

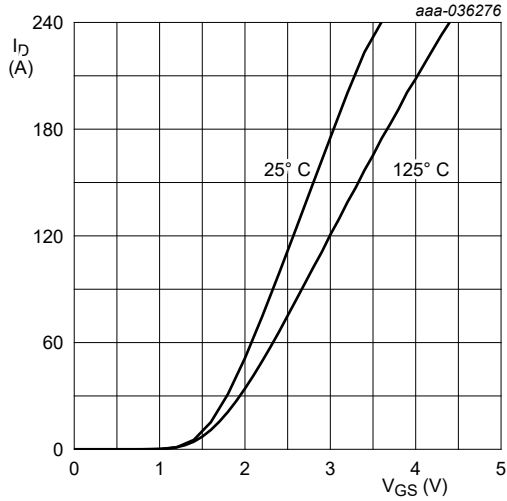
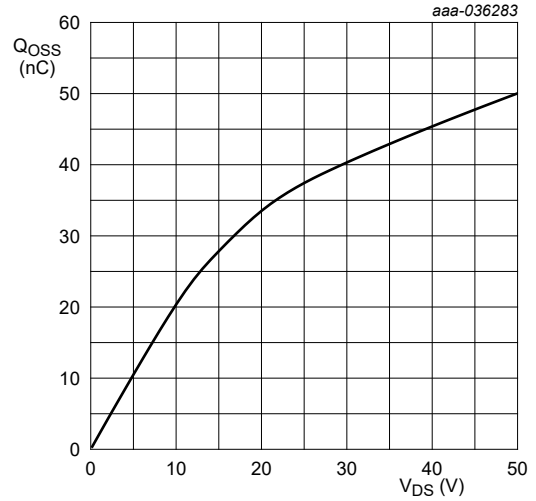
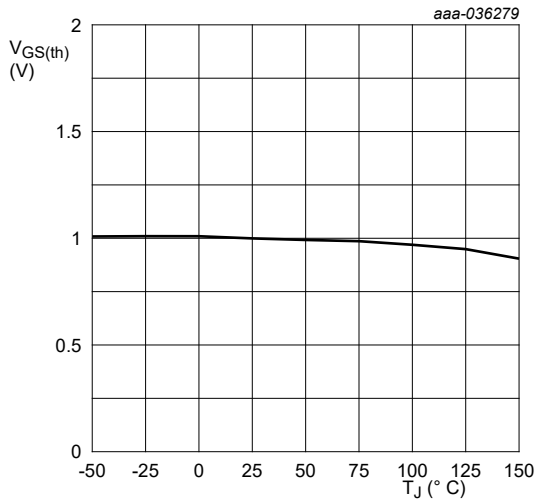


Fig. 6. Transfer characteristics; drain current as a function of gate-source voltage; typical values



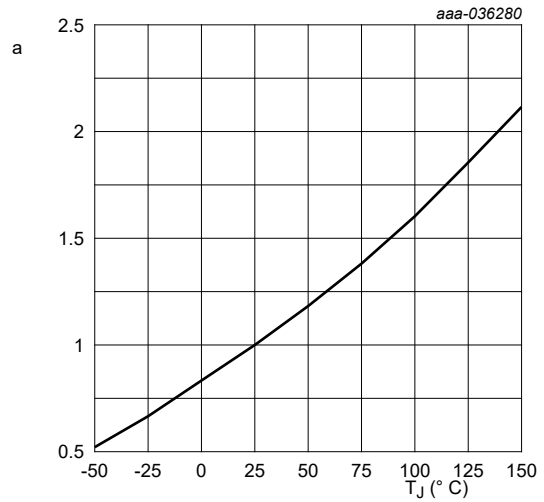
Freq. = 100 kHz

Fig. 7. Output charge as a function of drain-source voltage; typical values



$I_D = 9 \text{ mA}$; $V_{DS} = V_{GS}$

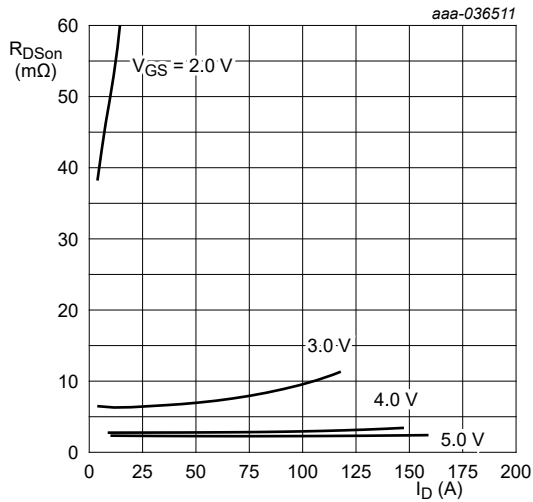
Fig. 8. Gate-source threshold voltage as a function of junction temperature



$$a = \frac{R_{DSon}}{R_{DSon}(25^\circ\text{C})}$$

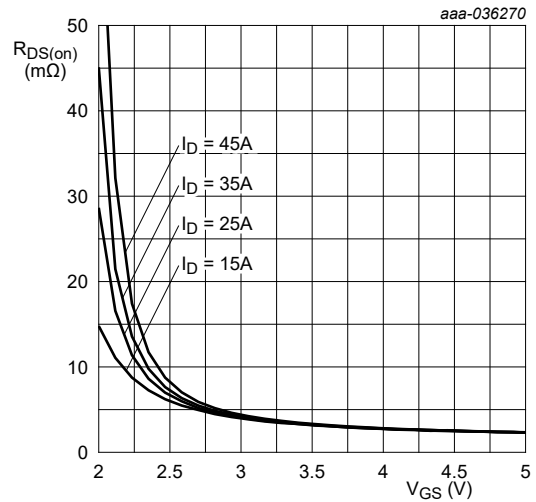
Fig. 9. Normalized drain-source on-state resistance factor as a function of junction temperature

100 V, 3.2 mOhm Gallium Nitride (GaN) FET in a 3.5 mm x 2.13 mm Wafer Level Chip-Scale Package (WLCSP)



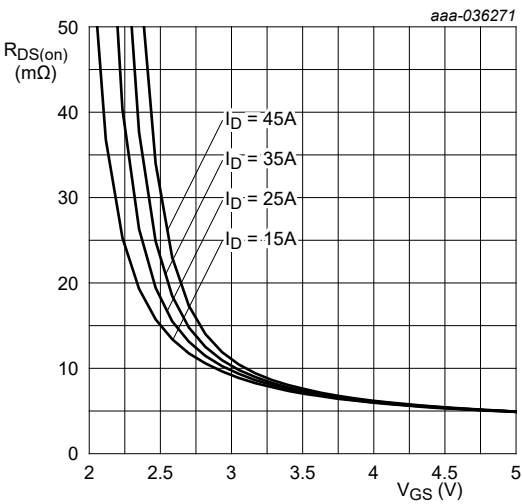
$T_j = 25^\circ\text{C}$

Fig. 10. Drain-source on-state resistance as a function of drain current ; typical values



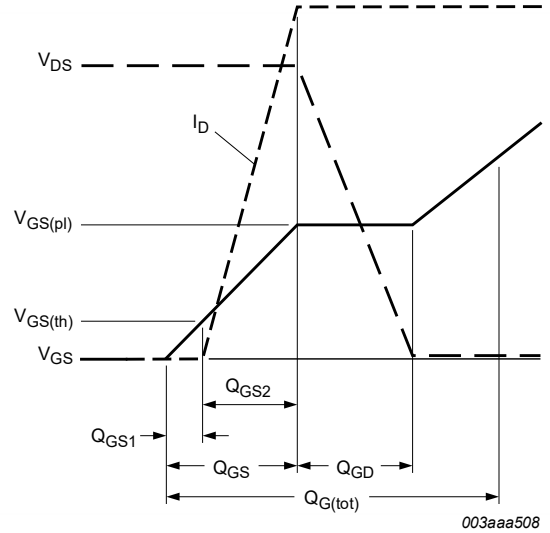
$T_j = 25^\circ\text{C}$

Fig. 11. Drain-source on-state resistance as a function of gate-source voltage; typical values



$T_j = 125^\circ\text{C}$

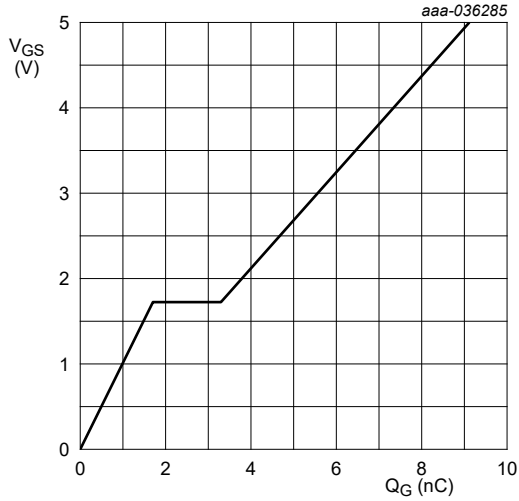
Fig. 12. Drain-source on-state resistance as a function of gate-source voltage; typical values



003aaa508

Fig. 13. Gate charge waveform definitions

100 V, 3.2 mOhm Gallium Nitride (GaN) FET in a 3.5 mm x 2.13 mm Wafer Level Chip-Scale Package (WLCSP)



$T_J = 25\text{ }^\circ\text{C}$; $I_D = 25\text{ A}$

Fig. 14. Gate-source voltage as a function of gate charge; typical values

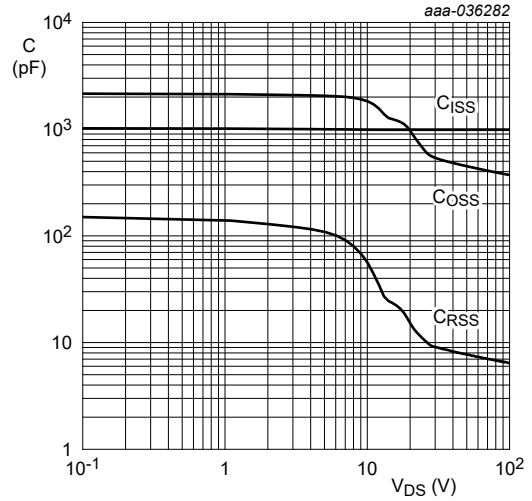
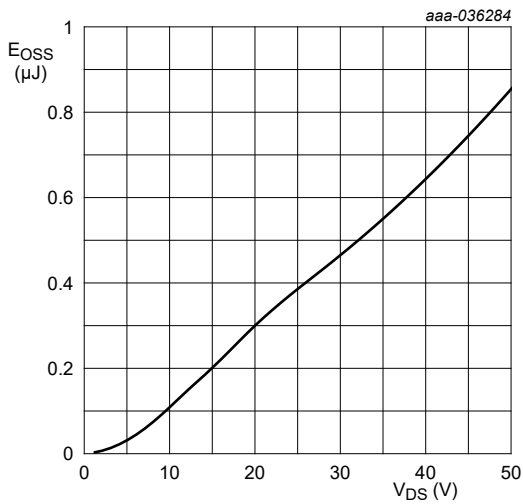
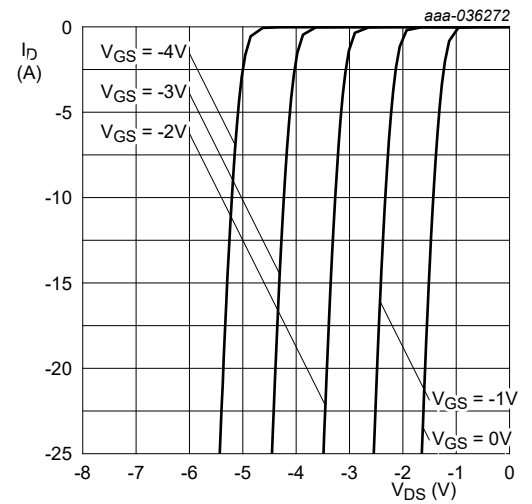


Fig. 15. Input, output and reverse transfer capacitances as a function of drain-source voltage; typical values



Freq. = 100 kHz

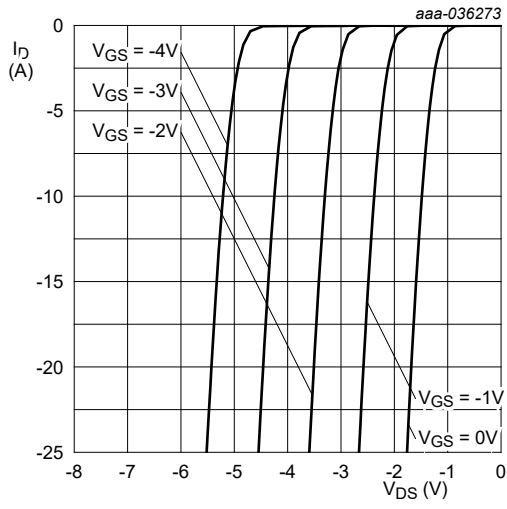
Fig. 16. COSS stored energy as a function of drain-source voltage; typical values



$T_j = 25\text{ }^\circ\text{C}$

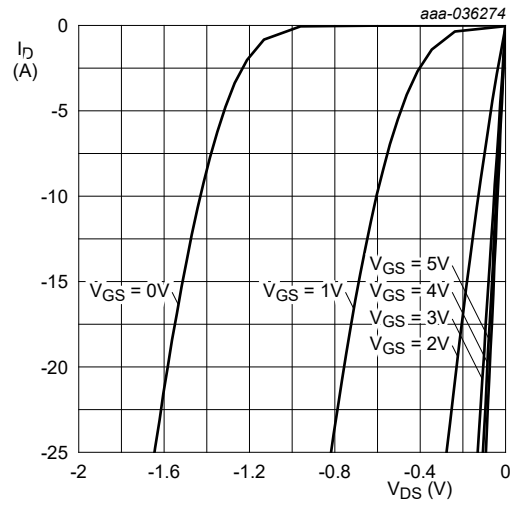
Fig. 17. Source current as a function of source-drain voltage; typical values

100 V, 3.2 mOhm Gallium Nitride (GaN) FET in a 3.5 mm x 2.13 mm Wafer Level Chip-Scale Package (WLCSP)



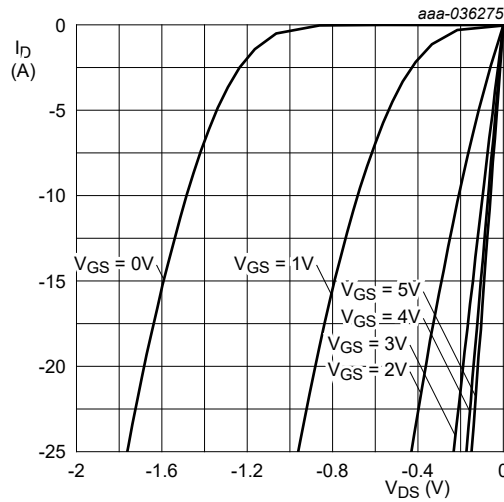
$T_j = 125\text{ °C}$

Fig. 18. Source current as a function of source-drain voltage; typical values



$T_j = 25\text{ °C}$

Fig. 19. Source current as a function of source-drain voltage; typical values



$T_j = 125\text{ °C}$

Fig. 20. Source current as a function of source-drain voltage; typical values

11. Package outline

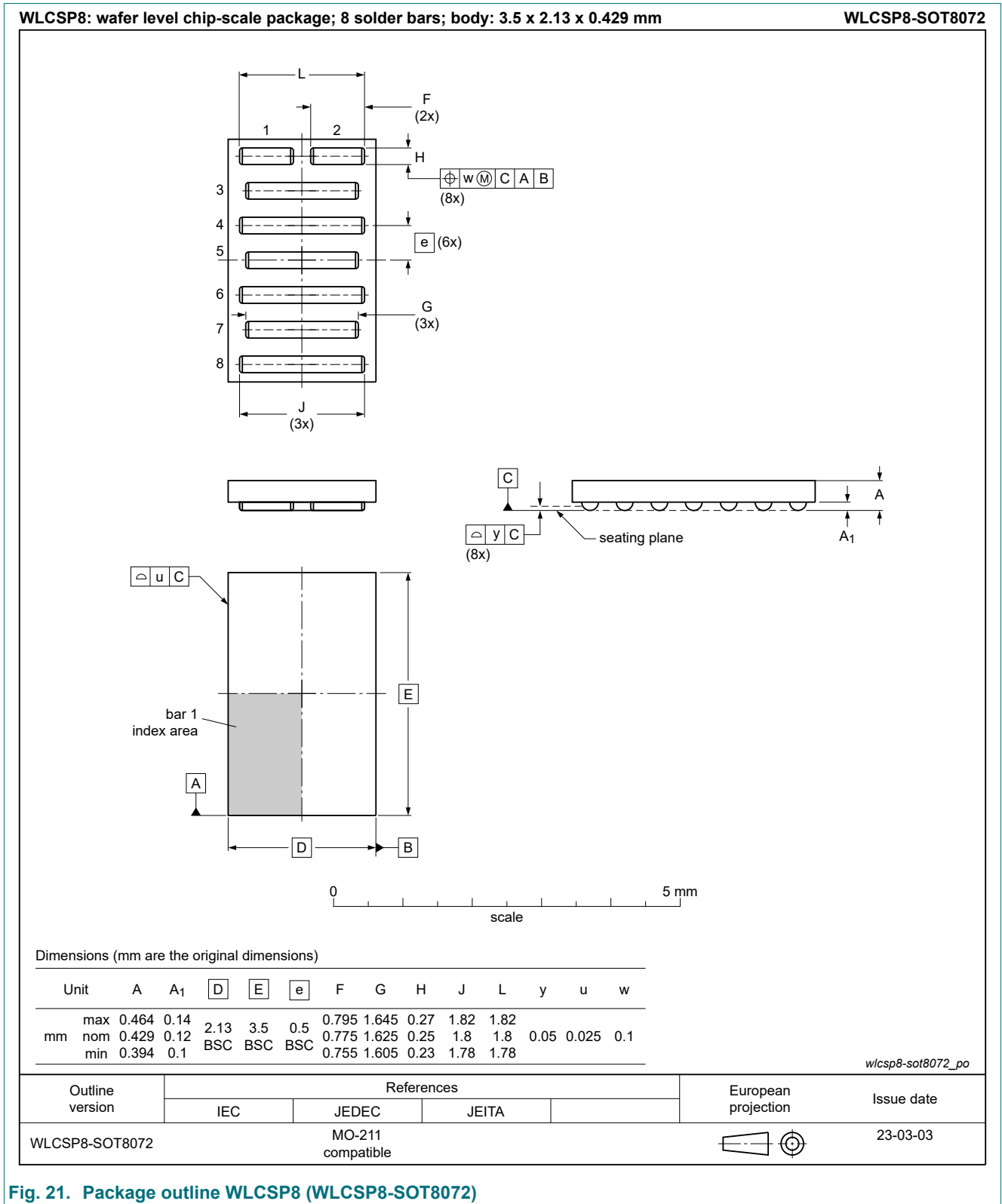


Fig. 21. Package outline WLCSP8 (WLCSP8-SOT8072)

12. Soldering

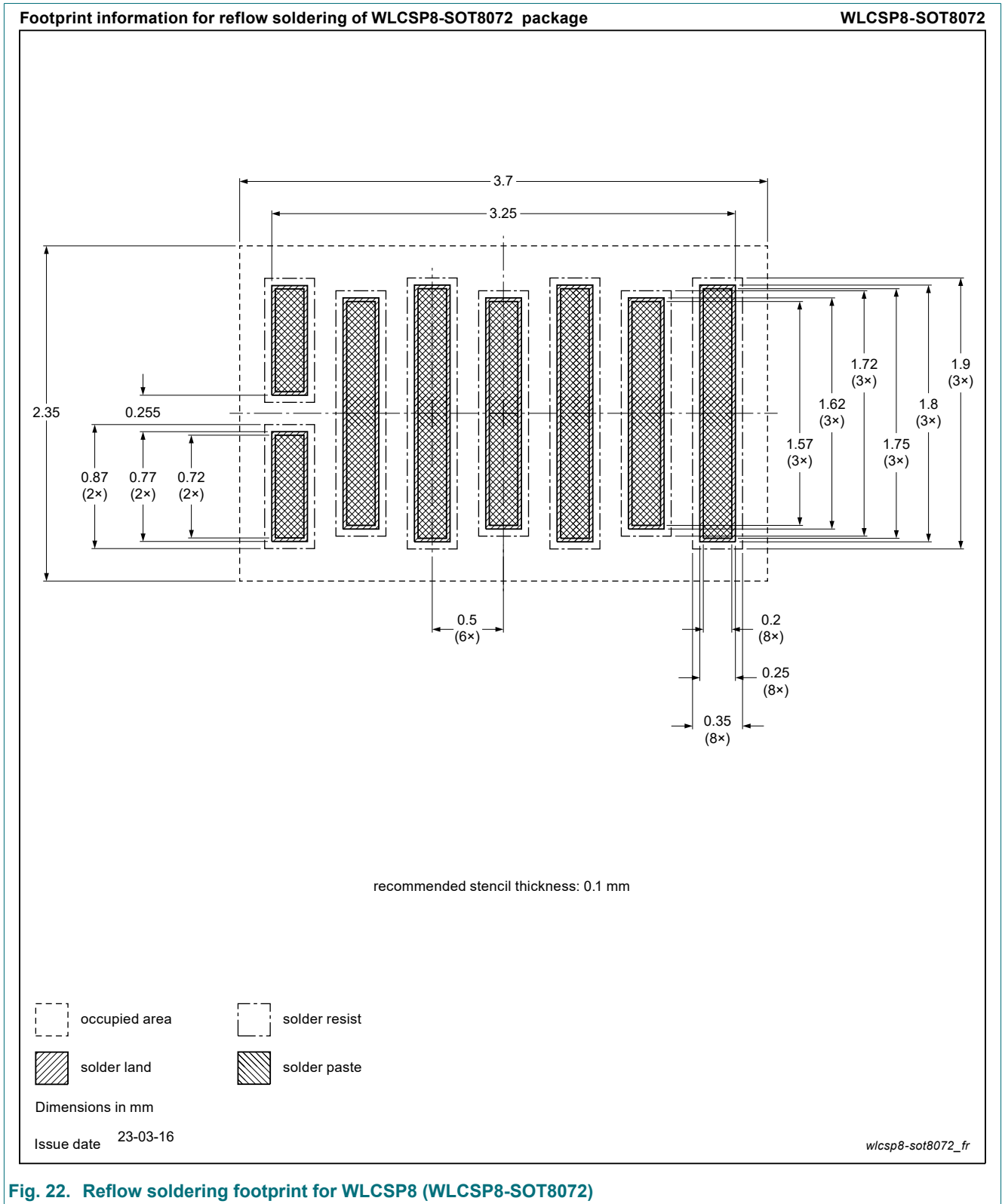


Fig. 22. Reflow soldering footprint for WLCSP8 (WLCSP8-SOT8072)

100 V, 3.2 mOhm Gallium Nitride (GaN) FET in a 3.5 mm x 2.13 mm Wafer Level Chip-Scale Package (WLCSP)

13. Legal information

Data sheet status

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|--------------------------------|--------------------|---|
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